

M4052BP
M4052BFP

DUAL 4-CHANNEL ANALOG MULTIPLEXER/DEMULTIPLEXER

6249826 MITSUBISHI ELEK (LINEAR)

80C 09109 D 7-51-11

DESCRIPTION

The M4052BP is a semiconductor integrated circuit consisting of two multiplexer/demultiplexers which use 2-bit digital inputs to perform selection of four analog switches.

FEATURES

- Low ON resistance: 50Ω typ. ($V_{DD}=15V$)
- High OFF resistance: $10^9\Omega$ or greater (typ)
- Small differences in ON resistance between each switch in the package: 10Ω typ. ($V_{DD}=7.5V, V_{SS}=-7.5V$)
- Linearized transfer characteristics: 0.07% distortion (typ)
- Signals with amplitude greater than the logic level amplitude of the control inputs may be switched.
- Provided with an inhibit input

APPLICATION

General purpose, for use in industrial and consumer digital equipment.

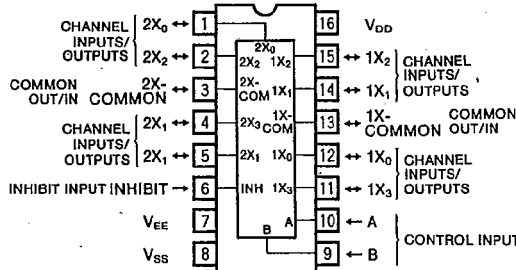
FUNCTIONAL DESCRIPTION

When a 2-bit binary input signal is applied to the control inputs (A and B), the channel number corresponding to the binary value input (X_0 through X_3) is set at low impedance with respect to the corresponding (X-COMMON). All other channels remain at high impedance.

In this operation, if the (INHIBIT) input is held high, all channels (X_0 through X_3) will be put in the high-impedance state, regardless of the state of the other inputs.

It is possible to switch an analog signal of amplitude $V_{DD}-V_{EE}$ if this is greater than the logic level span $V_{DD}-V_{SS}$ for inputs (A and B)

PIN COFIGRATION (TOP VIEW)

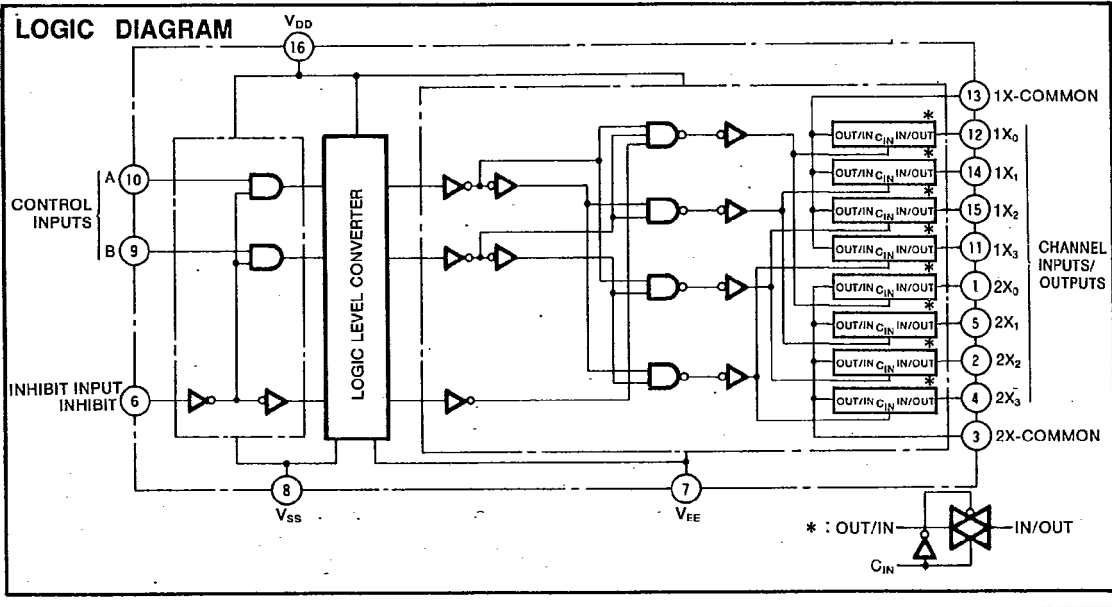


Outline 16P4
16P2N

FUNCTION TABLE (Note 1)

Inhibit input	Control inputs		Channel INPUT/OUTPUT to COMMON switch selection			
	B	A	X_0	X_1	X_2	X_3
L	L	L	ON	OFF	OFF	OFF
L	L	H	OFF	ON	OFF	OFF
L	H	L	OFF	OFF	ON	OFF
L	H	H	OFF	OFF	OFF	ON
H	X	X	OFF	OFF	OFF	OFF

Note 1 : X : Irrelevant
ON : Low impedance between X_n and X-COMMON ($n=0\sim3$)
OFF : High impedance between X_n and X-COMMON ($n=0\sim3$)



DUAL 4-CHANNEL ANALOG MULTIPLEXER/DEMULTIPLEXER

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ABSOLUTE MAXIMUM RATINGS (T_a = -40~+85°C, unless otherwise noted)

Symbol	Parameter	Conditions	Ratings	Unit
V _{DD} -V _{SS}	Supply voltage		-0.5~20	V
V _{DD} -V _{EE}			-0.5~20	V
V _I	Input voltage	Control and inhibit inputs	V _{SS} -0.5~V _{DD} +0.5	V
		Channel and common inputs	V _{EE} -0.5~V _{DD} +0.5	V
V _{IO}	Input-to-output voltage		±0.5	V
I _I	Input current	Control and inhibit inputs	±10	mA
I _O	Output current	Switch-off	±10	mA
V _O	Output voltage	Channel and common outputs	V _{EE} -0.5~V _{DD} +0.5	V
T _{opr}	Operating temperature range		-40~+85	°C
T _{stg}	Storage temperature range		-65~+150	°C

RECOMMENDED OPERATING CONDITING CONDITIONS (T_a = -40~+85°C, unless otherwise noted)

Symbol	Parameter	Limits			Unit
		Min	Typ	Max	
V _{DD} -V _{SS}	Supply voltage	3		18	V
V _{DD} -V _{EE}		3		18	V
V _I	Input voltage				V
	Control and inhibit inputs	V _{SS}		V _{DD}	
	Channel and common inputs	V _{EE}		V _{DD}	
V _O	Output voltage	V _{EE}		V _{DD}	V

ELECTRICAL CHARACTERISTICS (V_{SS}=0V)

Symbol	Parameter	Test conditions	Limits						Unit			
			-40°C		25°C		85°C					
			V _{EE} (V)	V _{DD} (V)	Min	Max	Min	Typ		Max	Min	Max
V _{IH}	"H" Input voltage (A, B, INHIBIT)	Input-to-output current=10μA	0	5	3.5		3.5			3.5		V
			0	10	7.0		7.0			7.0		
			0	15	11.0		11.0			11.0		
V _{IL}	"L" Input current (A, B, INHIBIT)	Input-to-output current=10μA	0	5		1.5			1.5		1.5	V
			0	10		3.0			3.0		3.0	
			0	15		4.0			4.0		4.0	
R _{ON}	ON resistance	V _I =5V	0	5		500			600		800	Ω
		V _I =2.5V	0	5		850			950		1300	
		V _I =0.25V	0	5		500			600		800	
		V _I =10V	0	10		210			250		300	
		V _I =5V	0	10		210			250		300	
		V _I =0.25V	0	10		210			250		300	
		V _I =15V	0	15		140			160		200	
		V _I =7.5V	0	15		140			160		200	
		V _I =0.25V	0	15		140			160		200	
		V _I =5V	-5	5		210			250		300	
		V _I =±0.25V	-5	5		210			250		300	
		V _I =-5V	-5	5		210			250		300	
ΔR _{ON}	ON resistance variations between switches of the same package	Test circuit 1	V _I =7.5V	-7.5	7.5		140			160		200
			V _I =±0.25V	-7.5	7.5		140			160		200
			V _I =-7.5V	-7.5	7.5		140			160		200
I _{OFF}	Input-to-output off-state leakage current (X ₀ ~X ₃ -X-COMMON)	V _{IO} =10V, V _{ON} =0V	0	10					125			nA
		V _{IO} =0V, V _{ON} =10V	0	10					-125			
		V _{IO} =18V, V _{ON} =0V	0	18		250			250		1000	
		V _{IO} =0V, V _{ON} =18V	0	18		-250			-250		-1000	
I _{DD}	Quiescent supply current	V _I =V _{DD} , V _{SS}	0	5		20			20		150	μA
			0	10		40			40		300	
			0	15		80			80		600	
I _{IH}	"H" input current (A, B, INH)	V _{IH} =18V	0	18		0.3			0.3		1.0	μA
I _{IL}	"L" input current (A, B, INH)	V _{IL} =0V	0	18		-0.3			-0.3		-1.0	μA

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SWITCHING CHARACTERISTICS (T_a=25°C, V_{ss}=0V)

Symbol	Parameter	Tset conditions	Limits			Unit
			V _{EE} (V)	V _{DD} (V)	Max	
f _{max(I/O)}	Maximum transfer frequency	R _L =10kΩ C _L =15pF Test circuit 2	-5	5	25	MHz
t _{PLH}	"L-H" and "H-L" output propagation time (A, B-X ₀ ~X ₃ , X-COMMON)	R _L =10kΩ C _L =50pF Test circuit 3	0	5	1000	ns
			0	10	500	
			0	15	400	
			-5	5	700	
			-7.5	7.5	500	
t _{PHL}	"L-H" and "H-L" output propagation time (A, B-X ₀ ~X ₃ , X-COMMON)	R _L =10kΩ C _L =50pF Test circuit 3	0	5	1000	ns
			0	10	500	
			0	15	400	
			-5	5	700	
			-7.5	7.5	500	
t _{PLH}	"L-H" and "H-L" output propagation time (INHIBIT-X ₀ ~X ₃ , X-COMMON)	R _L =10kΩ C _L =50pF Test circuit 4	0	5	1400	ns
			0	10	700	
			0	15	500	
			-5	5	900	
			-7.5	7.5	500	
t _{PHL}	"L-H" and "H-L" output propagation time (INHIBIT-X ₀ ~X ₃ , X-COMMON)	R _L =10kΩ C _L =50pF Test circuit 4	0	5	1400	ns
			0	10	700	
			0	15	500	
			-5	5	900	
			-7.5	7.5	500	
t _{PLH}	"L-H" and "H-L" output propagation time (X ₀ ~X ₃ /X-COMMON-X-COMMON/X ₀ ~X ₃)	R _L =10kΩ C _L =50pF Test circuit 5	0	5	45	ns
			0	10	30	
			0	15	20	
t _{PHL}	"L-H" and "H-L" output propagation time (X ₀ ~X ₃ /X-COMMON-X-COMMON/X ₀ ~X ₃)	R _L =10kΩ C _L =50pF Test circuit 5	0	5	45	ns
			0	10	30	
			0	15	20	
—	Sine-wave distortion	R _L =10kΩ f _i =1kHz Test circuit 2	-5	5	0.1	%
—	Feedthrough (switch off)	R _L =1kΩ Test circuit 6	-5	5	500	kHz
—	Crosstalk (A, B, INHIBIT-X ₀ ~X ₃ , X-COMMON)	R _i =1kΩ R _L =10kΩ C _L =15pF Test circuit 7	0	5	200	mV
			0	10	300	
			0	15	400	
C _i	Input capacitance	Control and inhibit inputs			7.5	pF
		Channel and common inputs			10	

TEST CIRCUITS (V_{ss}=0V, capacitance C_L includes stray wiring capacitance and probe input capacitance)

1 ON resistance (R_{ON})

$$R_{ON} = 10 \times \frac{(V_i - V_o)}{V_o} \text{ (k}\Omega\text{)}$$

Refer to the function table for conditions of control inputs A and B.

2 Maximum transfer frequency (f_{max(I/O)}). Sine-wave distortion

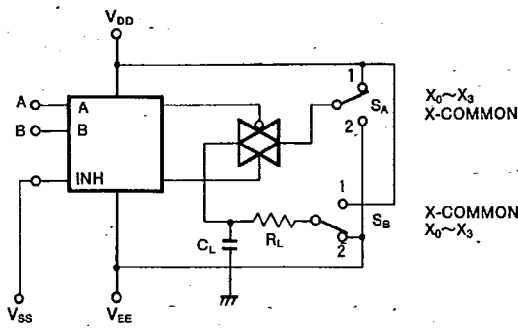
f_{max(I/O)} is taken as that frequency f_i at which, using a sine-wave input of 2.5V_{p-p}, 20 log₁₀(V_o/V_i) = -3dB. Refer to the function table for conditions of control inputs A and B.

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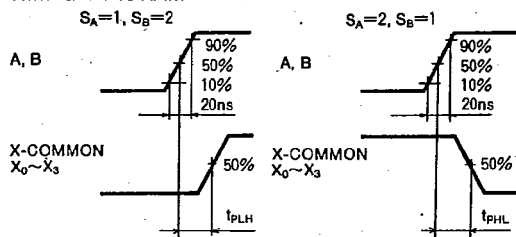
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3 "L-H" and "H-L" output propagation time
(A, B-X₀-X₃, COMMON)

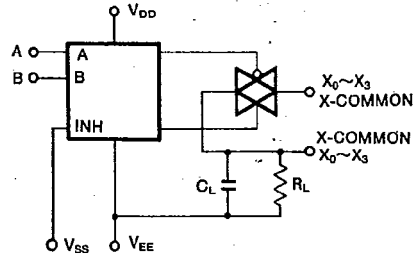


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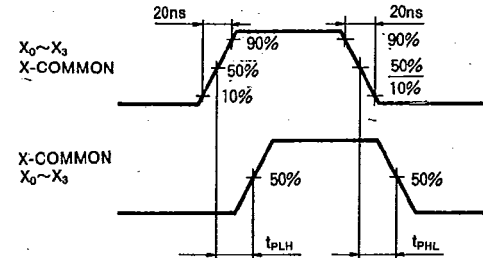


Refer to the function table for conditions of control inputs A and B.

5 "L-H" and "H-L" output propagation time
(X₀-X₃/X-COMMON-X-COMMON/X₀-X₃)

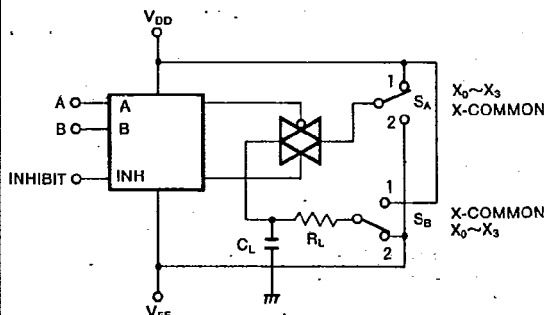


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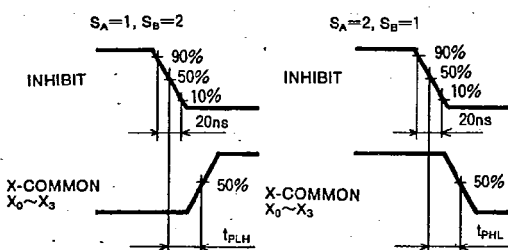


Refer to the function table for conditions of control inputs A and B.

4 "L-H" and "H-L" output propagation time
(INHIBIT-X₀-X₃, X-COMMON)

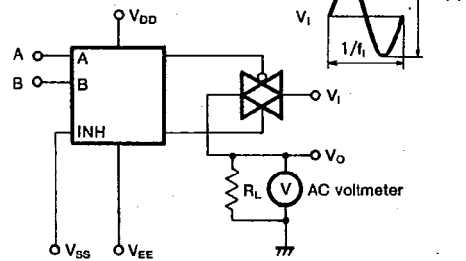


TIMNG DIAGRAM



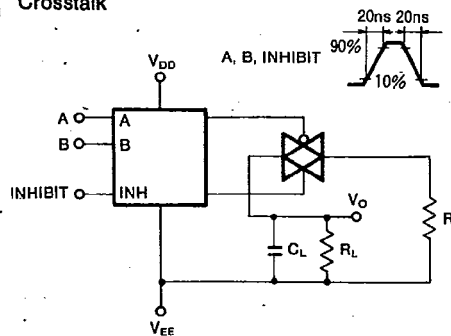
Refer to the function table for conditions of control inputs A and B.

6 Feedthrough



The feedthrough is taken as that frequency f_i at which, using a sine-wave input of $2.5V_{P-P}$, $20 \log_{10}(V_o/V_i) = -50dB$. Refer to the function table for conditions of control inputs A and B.

7 Crosstalk



Refer to the function table for conditions of control inputs A and B.